


<b>Search Notes</b>  	<b>Application/Control No.</b>  10577085	<b>Applicant(s)/Patent Under Reexamination</b>  KAPOOR, AJAY
	<b>Examiner</b>  O'Neill, Patrick	<b>Art Unit</b>  2816

SEARCHED			
Class	Subclass	Date	Examiner
327	416, 419, 427, 434-437	06/22/07	PO
327	318, 319, 333, 379, 382-384, 387-389, 391	10/5/07	PO

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (all databases)	06/22/07	PO
IEEE Xplore	06/22/07	PO
Google	06/22/07	PO
Inventor Search	06/22/07	PO
Consulted with Linh Nguyen (Primary)	06/22/07	PO
Updated EAST (all databases) search	10/5/07	PO
Consulted with Tuan Lam (Primary)	10/5/07	PO

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
All	USPGPUB text search	10/5/07	PO